

Hall Effect Sensor with Complementary Output

◆ General Description

The GH276 is an integrated Hall sensor with output driver designed for electronic commutation of brushless DC motor applications. The device includes an on-chip Hall sensor for magnetic sensing, an amplifier that amplifies the Hall voltage, a Schmitt trigger to provide switching hysteresis for noise rejection, a temperature compensation circuit to compensate the temperature drift of Hall sensitivity and two complementary open-collector drivers for sinking large load current. It also includes an internal band-gap regulator which is used to provide bias voltage for internal circuits.

Placing the device in a variable magnetic field, if the magnetic flux density is larger than threshold B_{OP} , the pin DO will be turned low (on) and pin DOB will be turned high (off). This output state is held until the magnetic flux density reverses and falls below B_{RP} , then causes DO to be turned high (off) and DOB turned low (on).

GH276 is available in TO-94 (SIP-4L) package.

◆ Features

- On-Chip Hall Sensor
- 3.5V to 20V Supply Voltage
- 300mA (avg) Output Sink Current
- Reversed Supply Voltage Protection
- Build in Over Temperature Protection Function
- -20°C to 85°C Operating Temperature
- Low Profile TO-94 (SIP-4L) Package

◆ Applications

- Dual-Coil Brushless DC Motor
- Dual-Coil Brushless DC Fan
- Revolution Counting
- Speed Measurement

◆ Typical Applications

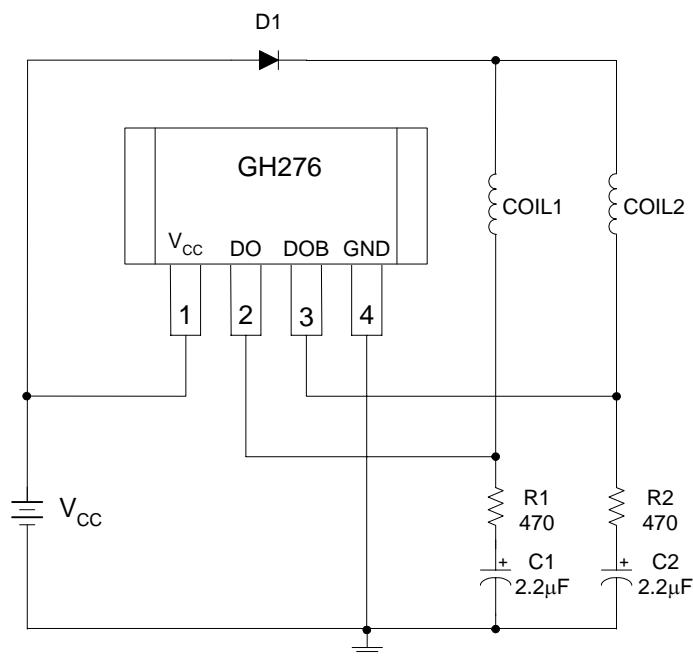


Figure 1. Typical Application Circuit

◆ Pin Configuration

TO-94(SIP-4L)

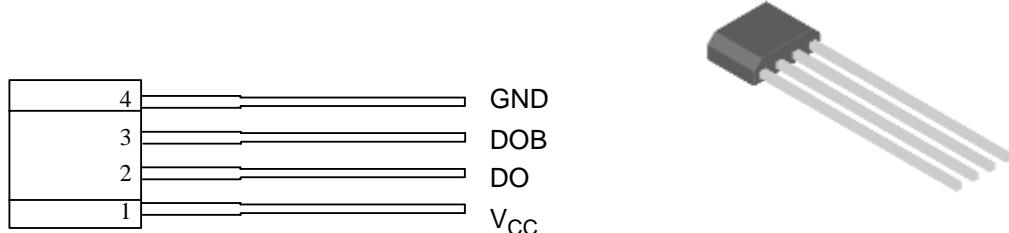


Figure 2. Pin Configuration of GH276 (Front View)

◆ Pin Description

| Pin Number | Pin Name | Function |
|------------|-----------------|---|
| 1 | V _{CC} | IC Power Supply voltage |
| 2 | DO | Coil Driver Output 1, It is Low state during the N magnetic field |
| 3 | DOB | Coil Driver Output 2, It is Low state during the S magnetic field |
| 4 | GND | IC Ground |

◆ Functional Block Diagram

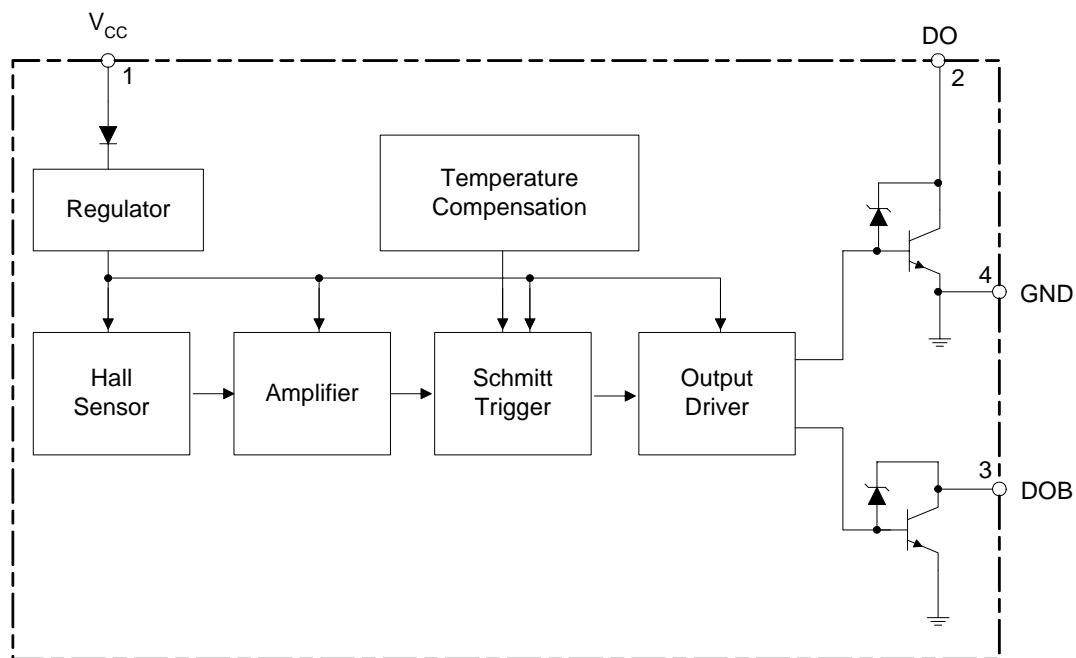


Figure 3. Functional Block Diagram of GH276

◆ Absolute Maximum Ratings (Note 1)

($T_A=25^\circ\text{C}$)

| Parameter | Symbol | Value | Unit |
|----------------------------|---------------------|------------|---------------------------|
| Supply Voltage | V_{CC} | 20 | V |
| Reverse Protection Voltage | V_{RCC} | -20 | V |
| Magnetic Flux Density | B | Unlimited | Gauss |
| Output Current | Continuous | 300 | mA |
| | Hold | 400 | mA |
| | Peak (start up) | 600 | mA |
| Power Dissipation | P_D | 550 | mW |
| Thermal Resistance | Die to atmosphere | 0JA | $^\circ\text{C}/\text{W}$ |
| | Die to package case | 0JC | $^\circ\text{C}/\text{W}$ |
| Storage Temperature | T_{STG} | -50 to 150 | $^\circ\text{C}$ |

Note 1: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "Recommended Operating Conditions" is not implied. "Absolute Maximum Ratings" for extended period may affect device reliability.

◆ Recommended Operating Conditions

($T_A=25^\circ\text{C}$)

| Parameter | Symbol | Min | Max | Unit |
|---------------------|----------|-----|-----|------------------|
| Supply Voltage | V_{CC} | 3.5 | 20 | V |
| Ambient Temperature | T_A | -20 | 85 | $^\circ\text{C}$ |

◆ Electrical Characteristics

($T_A=25^\circ\text{C}$, $V_{CC}=14\text{V}$, unless otherwise specified)

| Parameter | Symbol | Test Condition | Min | Typ | Max | Unit |
|--------------------------------|------------|---|-----|------|-----|---------------|
| Output Saturation Voltage | V_{SAT} | $V_{CC}=3.5\text{V}$, $I_O=100\text{mA}$ | | 0.1 | | V |
| | | $I_O=300\text{mA}$ | | 0.35 | 0.6 | V |
| Output Leakage Current | I_{OL} | $V_{CE}=16\text{V}$ | | 0.1 | 10 | μA |
| Supply Current | I_{CC} | $V_{CC}=16\text{V}$, Output Open | 6 | 13 | 18 | mA |
| Output Rise Time | tr | $R_L=820\Omega$, $C_L=20\text{pF}$ | | 3.0 | 10 | μs |
| Output Fall Time | tf | $R_L=820\Omega$, $C_L=20\text{pF}$ | | 0.3 | 1.5 | μs |
| Switch Time Differential | Δt | $R_L=820\Omega$, $C_L=20\text{pF}$ | | 3.0 | 10 | μs |
| Output Zener Breakdown Voltage | V_Z | | | 55 | | V |

◆ Magnetic Characteristics

($T_A=25^\circ\text{C}$)

| Parameter | Symbol | Grade | Min | Typ | Max | Unit |
|-----------------|-----------|-------|------|-----|-----|-------|
| Operating Point | B_{OP} | A | 10 | | 50 | Gauss |
| | | B | 5 | | 70 | Gauss |
| | | C | | | 100 | Gauss |
| Releasing Point | B_{RP} | A | -50 | | -10 | Gauss |
| | | B | -70 | | -5 | Gauss |
| | | C | -100 | | | Gauss |
| | B_{HYS} | | | 65 | | Gauss |

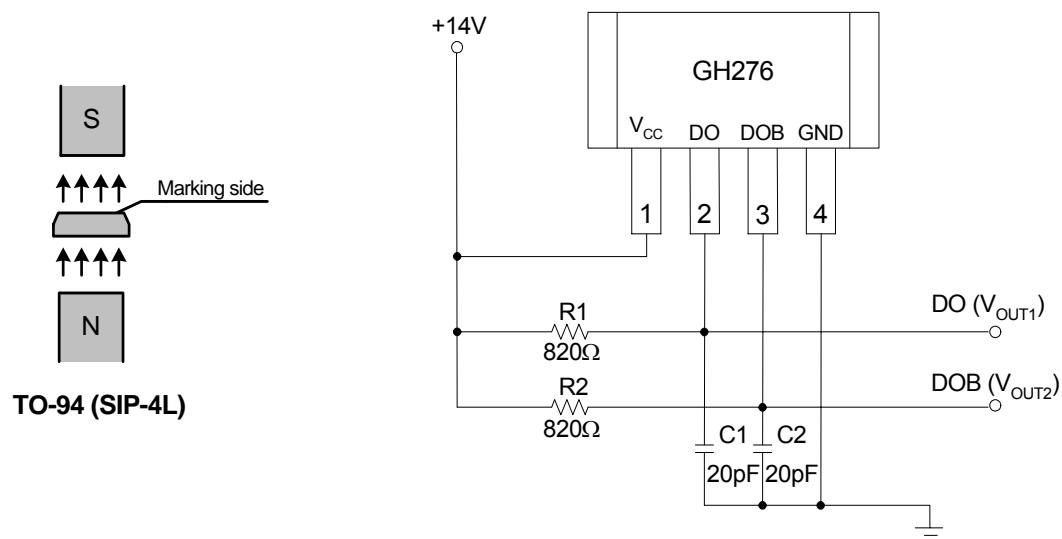
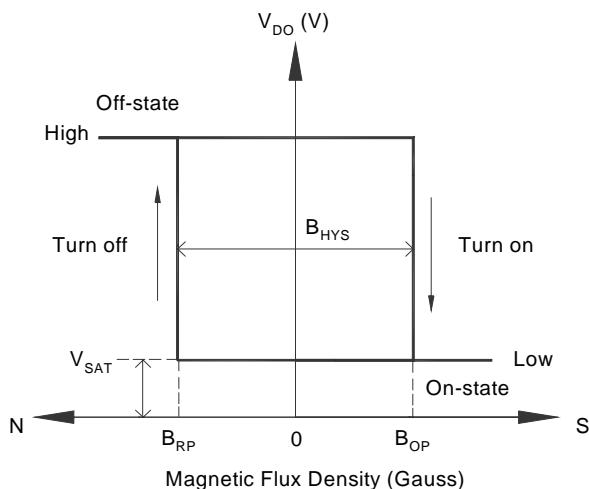


Figure 4. Basic Test Circuit

◆ Magnetic Characteristics (Continued)

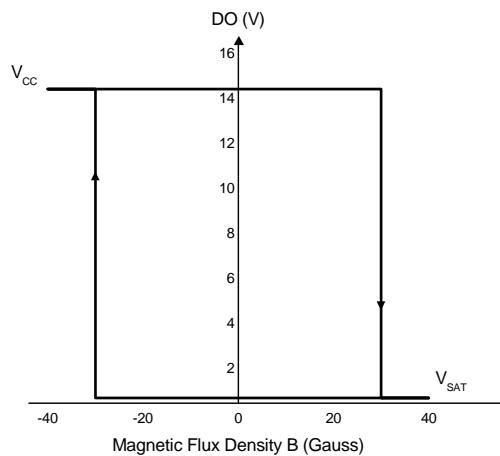


Figure 5. V_{DO} vs. Magnetic Flux Density

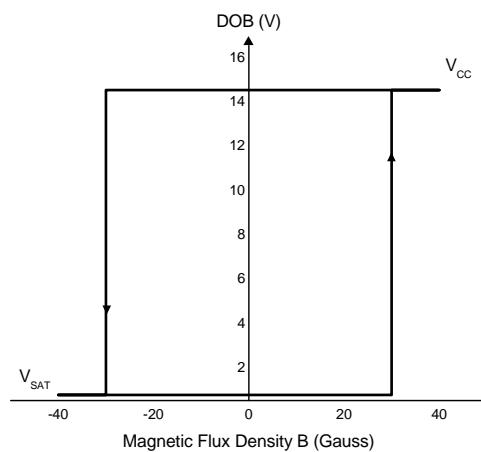
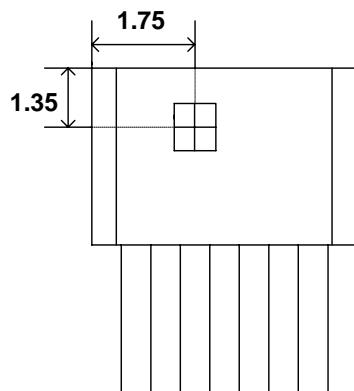


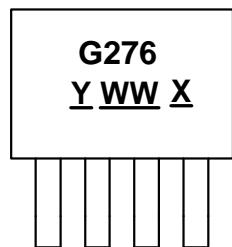
Figure 6. V_{DOB} vs. Magnetic Flux Density

◆ Package Sensor Location (Unit:mm)



◆ Marking Information

(Top View)



Y : Year : 0~9, "1"=2011

WW : Nth Weeks (01~52)

X : Internal Code



◆ Package Information

Unit: mm

TO-94(SIP-4L)

